SL3S1205_15

UCODE 8/8m

Rev. 3.2 — 19 November 2018
398432

Product data sheet
COMPANY PUBLIC

1 General description

The UCODE 8 and UCODE 8m ICs are the latest NXP products of the UCODE family. UCODE 8/8m offers best-in-class performance and features for use in the most demanding RFID tagging applications.

Particularly well suited for inventory management applications, like e.g Retail and Fashion, with its leading-edge RF performance for any given form factor, UCODE 8/8m enables long read distance and fast inventory of dense RFID tag population. With its broadband design, it offers the possibility to manufacture true global RFID label with best-in-class performance over worldwide regulations.

The device also provides a Self Adjust Feature, a Product Status Flag for Electronic Article Surveillance (EAS) application, pre-serialized 96-bit EPC, Brand Identifier and the EPC Gen2v2 compliant Untraceable command.

2 Features and benefits

2.1 Key features

- Read sensitivity -23 dBm
- Write sensitivity -18 dBm
- Innovative functionality
  - Self Adjust
  - Memory Safeguard
  - Brand Identifier
  - Untraceable
  - Pre-serialization for 96-bit EPC
  - Integrated Product Status Flag (PSF)
- Compatible with single-slit antenna
- Up to 128-bit EPC
- 96-bit Unique Tag Identifier (TID) factory locked, including 48-bit unique serial number
- EPC Gen2v2

2.1.1 Memory

- 128-bit/96-bit (UCODE 8/UCODE 8m) of EPC memory
- Supports pre-serialization for 96-bit EPC
- 96-bit Tag IDentifier (TID) factory locked
- 48-bit unique serial number factory-encoded into TID
- 0-bit/32-bit (UCODE 8/UCODE 8m) User Memory
- 32-bit kill password to permanently disable the tag
- 32-bit access password
- Wide operating temperature range: -40 °C up to +85 °C
- Minimum 100k write cycle endurance

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2.2 Supported features

- All mandatory commands of EPC global specification V.2.0.1 are implemented including:
  - Lock or permalock
  - Kill Command
- The following optional commands are implemented in conformance with the EPC specification:
  - Access
  - BlockWrite (2 words, 32-bit)
  - Untraceable
- Product Status Flag bit: enables the UHF RFID tag to be used as EAS (Electronic Article Surveillance) tag without the need for a back-end database.
- Self Adjust for automated tag performance optimization
- Memory Safeguard: enables countermeasures, like parity and margin checks as well as automated error correction, to ensure integrity of customer data.
- Brand Identifier: enables product authentication verification

All supported features of UCODE 8/8m can be activated using standard EPCglobal READ / WRITE / ACCESS / SELECT commands. No custom commands are needed to take advantage of all the features.

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3 Applications

3.1 Target market

- Retail
  - Brick and mortar
  - e-commerce
  - omnichannel
- Supply chain management
- Shipping services
- Airline luggage tracking
- Laundry services

3.2 Applications

- High accurate and fast inventory management, enabling omnichannel retail processes
- Tracking along the supply chain from source to store
- High-speed store checkout process, bringing convenience to the customer
- Loss prevention
- Brand Protection
- After sales operations: Return and Warranty management

Outside the applications mentioned above, please contact NXP Semiconductors for support.

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4 Ordering information

Table 1. Ordering information

Type number	Package			
	Name	IC type	Description	Version
SL3S1205FUD/HA	Wafer	UCODE 8	Die on sawn 8" 120 µm wafer 10 µm Polyimide spacer with Large Pads	not applicable
SL3S1215FUD/HA	Wafer	UCODE 8m	Die on sawn 8" 120 µm wafer 10 µm Polyimide spacer with Large Pads	not applicable
SL3S1205FUD2/HA	Wafer	UCODE 8	Die on sawn 12" 120 µm wafer 10 µm Polyimide spacer with Large Pads	not applicable
SL3S1215FUD2/HA	Wafer	UCODE 8m	Die on sawn 12" 120 µm wafer 10 µm Polyimide spacer with Large Pads	not applicable

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5 Block diagram

The UCODE 8/8m IC consists of three major blocks:

- Analog Interface
- Digital Control
- EEPROM

The analog part provides stable supply voltage and demodulates data received from the reader which is then processed by the digital part. Further, the modulation transistor of the analog part transmits data back to the reader.

The digital section includes the state machines, processes the protocol and handles communication with the EEPROM, which contains the EPC and the user data.

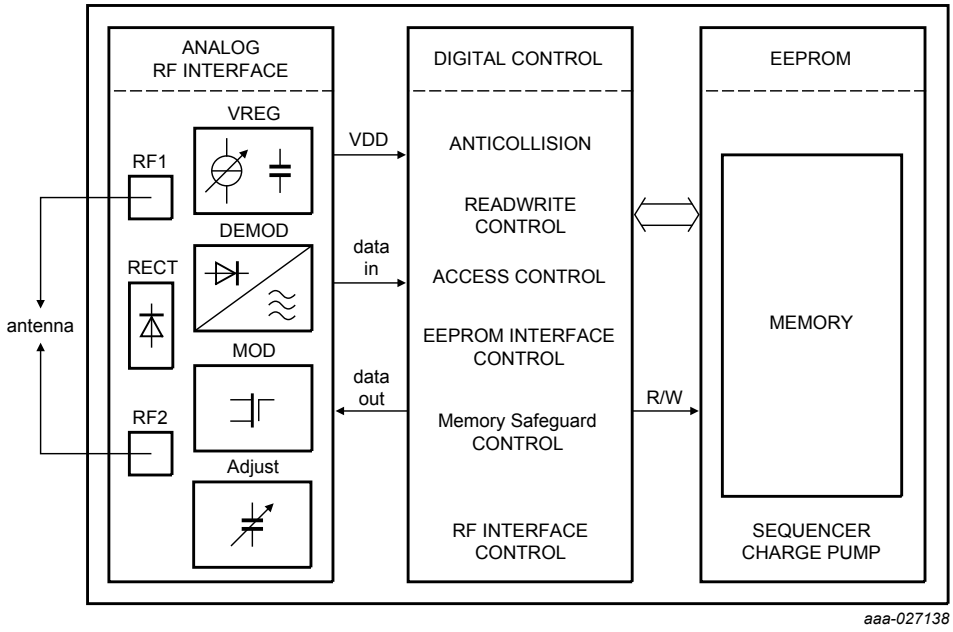


Figure 1. Block diagram of UCODE 8/8m IC

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6 Pinning information

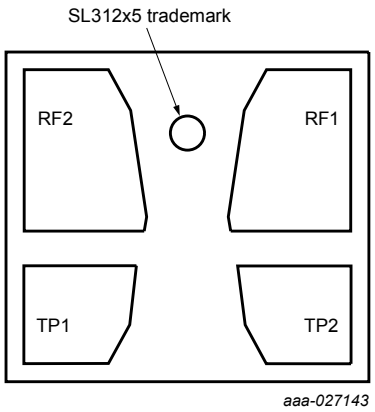


Figure 2. Pinning bare die

6.1 Pin description

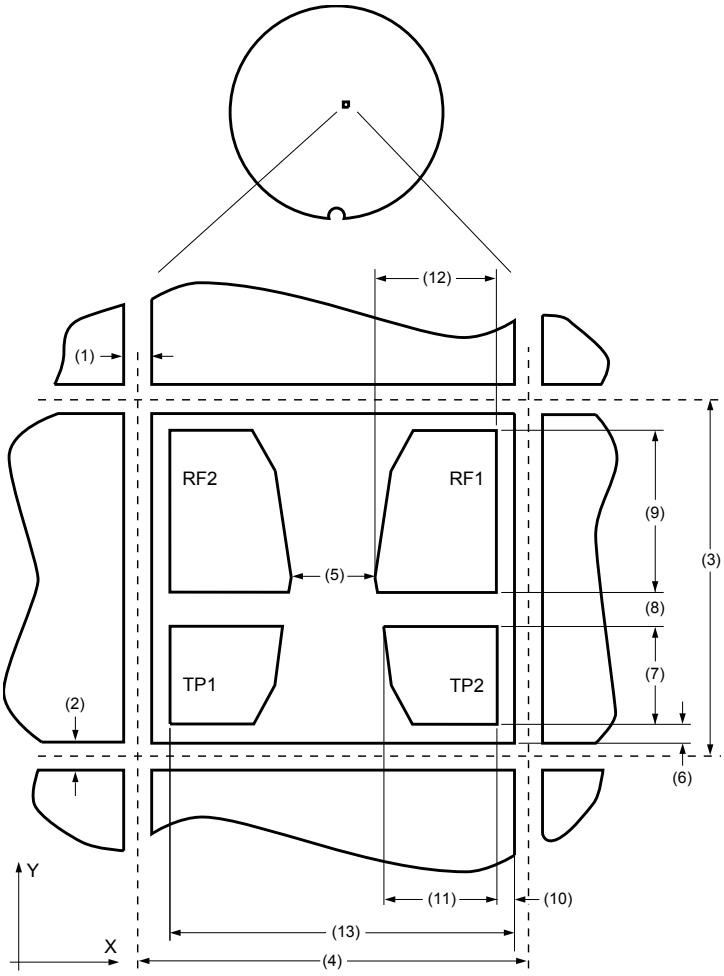
Table 2. Pin description bare die

Symbol	Description
TP1	test pad 1
RF1	antenna connector 1
TP2	test pad 2
RF2	antenna connector 2

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7 Wafer layout



not to scale!

aaa-027144

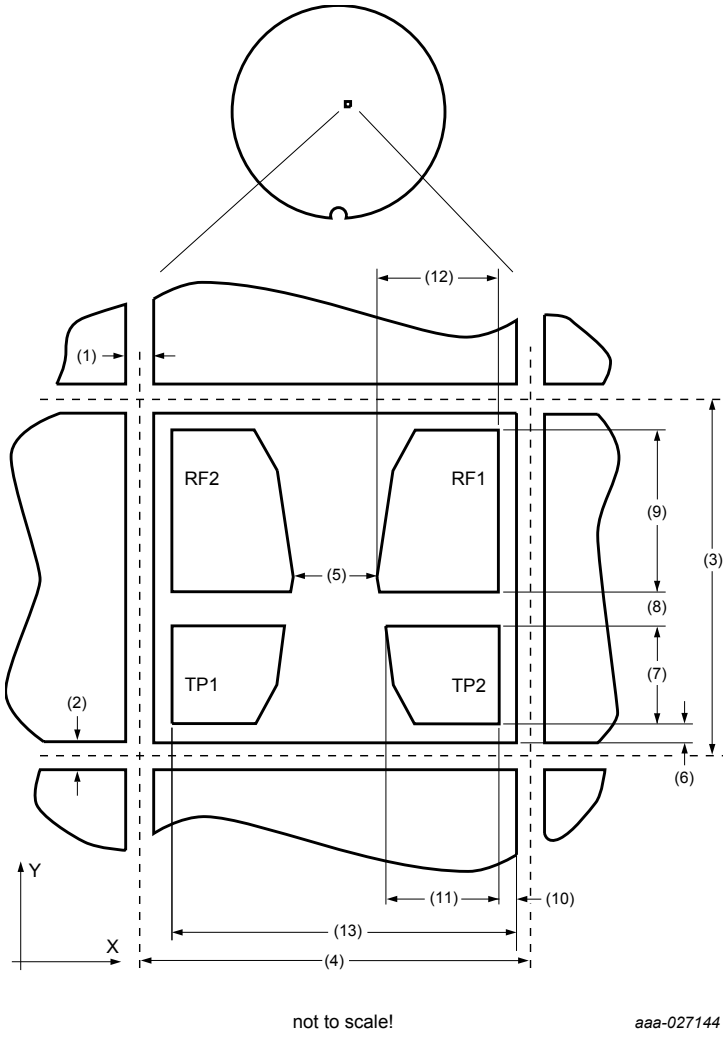
1. Die to Die distance (metal sealring - metal sealring) 19 µm, (X-scribe line width: 15 µm)
2. Die to Die distance (metal sealring - metal sealring) 19 µm, (Y-scribe line width: 15 µm)
3. Chip step, Y-length: 490 µm
4. Chip step, X-length: 480 µm
5. Bump to bump distance X (RF1 - RF2): 115 µm
6. Distance bump to metal sealring Y: 21.5 µm
7. Bump size (TP1, TP2) Y: 100 µm
8. Bump to bump distance Y (RF1 - TP2, RF2 - TP1): 50 µm
9. Bump size (RF1, RF2) Y: 278 µm
10. Distance bump to metal sealring X: 21.5 µm
11. Bump size (TP1, TP2) X: 134.2 µm
12. Bump size (RF1, RF2) X: 151.5 µm
13. Distance bump to metal sealring Y: 441.5 µm

Remark: *TP1 and TP2 are electrically disconnected after dicing*

Figure 3. UCODE 8/8m, 8" wafer layout

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1. Die to Die distance (metal sealring - metal sealring) 39 µm, (X-scribe line width: 35 µm)
2. Die to Die distance (metal sealring - metal sealring) 39 µm, (Y-scribe line width: 35 µm)
3. Chip step, Y-length: 510 µm
4. Chip step, X-length: 500 µm
5. Bump to bump distance X (RF1 - RF2): 115 µm
6. Distance bump to metal sealring Y: 21.5 µm
7. Bump size (TP1, TP2) Y: 100 µm
8. Bump to bump distance Y (RF1 - TP2, RF2 - TP1): 50 µm
9. Bump size (RF1, RF2) Y: 278 µm
10. Distance bump to metal sealring X: 21.5 µm
11. Bump size (TP1, TP2) X: 134.2 µm
12. Bump size (RF1, RF2) X: 151.5 µm
13. Distance bump to metal sealring Y: 441.5 µm

Remark: *TP1 and TP2 are electrically disconnected after dicing*

Figure 4. UCODE 8/8m, 12" wafer layout

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8 Mechanical specification

The UCODE 8 wafers are available in 120 µm thickness. The 120 µm thick wafer is enhanced with 10 µm Polyimide spacer resulting in less coupling between the antenna and the active circuit, leaving more room for process control (like pressure).

8.1 Wafer specification

8.1.1 8 inch Wafer

See "Data sheet - Delivery type description – General specification for 8" wafer on UV-tape with electronic fail die marking, BU-S&C document number: 1093**"

Table 3. 8 inch specification

Wafer	
Designation	each wafer is scribed with batch number and wafer number
Diameter	200 mm (8") unsawn- 205 mm typical sawn on foil
Thickness	120 µm ± 15 µm
Number of pads	4
Pad location	non-diagonal / placed in chip corners
Process	CMOS 0.14 µm
Batch size	25 wafers
Potential good dies per wafer	124960
Wafer backside	
Material	Si
Treatment	ground and stress release
Roughness	R_a max. 0.5 µm, R_t max. 5 µm
Chip dimensions	
Die size excluding scribe	0.465 mm × 0.475 mm = 0.22 mm^2
Scribe line width:	x-dimension = 15 µm
	y-dimension = 15 µm
Passivation on front	
Type	Sandwich structure
Material	PE-Nitride (on top)
Thickness	1.75 µm total thickness of passivation
Polyimide spacer	10 µm ± 2 µm
Au pads	
Pad material	> 99.9 % pure Au
Pad hardness	35 – 80 HV 0.005
Pad shear strength	> 70 MPa

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Pad height	3 µm
Pad height uniformity	
– within a die	max. 2 µm
– within a wafer	max. 4 µm
Pad flatness	max. 3 µm
Pad size	
– RF1, RF2 (max. details see wafer layout)	151.5 µm × 278 µm
– TP1, TP2 (max. details see wafer layout)	134.2 µm × 100 µm
Pad size variation	± 5 µm

8.1.2 12 inch Wafer

See "Data sheet - Delivery type description – General specification for 12" wafer on UV-tape with electronic fail die marking, BU-S&C document number: 1862**"

Table 4. 12 inch specification

Wafer	
Designation	each wafer is scribed with batch number and wafer number
Diameter	300 mm (12") unsawn
Thickness	120 µm ± 15 µm
Number of pads	4
Pad location	non-diagonal / placed in chip corners
Process	CMOS 0.14 µm
Batch size	25 wafers
Potential good dies per wafer	255279
Wafer backside	
Material	Si
Treatment	ground and stress release
Roughness	R_a max. 0.5 µm, R_t max. 5 µm
Chip dimensions	
Die size excluding scribe	0.465 mm × 0.475 mm = 0.22 mm^2
Scribe line width:	x-dimension = 35 µm
	y-dimension = 35 µm
Passivation on front	
Type	Sandwich structure
Material	PE-Nitride (on top)
Thickness	1.75 µm total thickness of passivation
Polyimide spacer	10 µm ± 2 µm
Au pads	

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Pad material	> 99.9 % pure Au
Pad hardness	35 – 80 HV 0.005
Pad shear strength	> 70 MPa
Pad height	3 µm
Pad height uniformity	
– within a die	max. 2 µm
– within a wafer	max. 4 µm
Pad flatness	max. 3 µm
Pad size	
– RF1, RF2 (max. details see wafer layout)	151.5 µm × 278 µm
– TP1, TP2 (max. details see wafer layout)	134.2 µm × 100 µm
Pad size variation	± 5 µm

8.1.3 Fail die identification

No ink dots are applied to the wafer.

Electronic wafer mapping (SECS II format) covers the electrical test results and additionally the results of mechanical/visual inspection.

See "Data sheet - Delivery type description – General specification for 8" wafer on UV-tape with electronic fail die marking, BU-S&C document number: 1093**"

See "Data sheet - Delivery type description – General specification for 12" wafer on UV-tape with electronic fail die marking, BU-S&C document number: 1862**"

8.1.4 Map file distribution

See "Data sheet - Delivery type description – General specification for 8" wafer on UV-tape with electronic fail die marking, BU-S&C document number: 1093**"

See "Data sheet - Delivery type description – General specification for 12" wafer on UV-tape with electronic fail die marking, BU-S&C document number: 1862**"

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9 Functional description

9.1 Air interface standards

The UCODE 8/8m fully supports all parts of the "EPC^{TM} Radio-Frequency Identity Protocols Generation-2 UHF RFID, Specification for RFID Air Interface, Protocol for Communications at 860 MHz to 960 MHz, Version 2.0.1".

9.2 Power transfer

The interrogator provides an RF field that powers the tag, equipped with a UCODE 8/8m. The antenna transforms the impedance of free space to the chip input impedance in order to get the maximum power for the UCODE 8/8m on the tag.

The RF field, which is oscillating on the operating frequency provided by the interrogator, is rectified to provide a smoothed DC voltage to the analog and digital modules of the IC.

The antenna that is attached to the chip may use a DC connection between the two antenna pads. Therefore the UCODE 8/8m also enables loop antenna design.

9.3 Data transfer

9.3.1 Interrogator to tag Link

An interrogator transmits information to the UCODE 8/8m by modulating an UHF RF signal. The UCODE 8/8m receives both information and operating energy from this RF signal. Tags are passive, meaning that they receive all of their operating energy from the interrogator's RF waveform.

An interrogator is using a fixed modulation and data rate for the duration of at least one inventory round. It communicates to the UCODE 8/8m by modulating an RF carrier.

For further details, refer to "Interrogator-to-tag (R=>T) communications"

9.3.2 Tag to interrogator Link

Upon transmitting a valid command, an interrogator receives information from a UCODE 8/8m tag by transmitting an unmodulated RF carrier and listening for a backscattered reply. The UCODE 8/8m backscatters by switching the reflection coefficient of its antenna between two states in accordance with the data being sent. For further details, refer to "Tag-to-Interrogator (T=>R) communications"

The UCODE 8/8m communicates information by backscatter-modulating the amplitude and/or phase of the RF carrier. Interrogators shall be capable of demodulating either demodulation type.

The encoding format, selected in response to interrogator commands, is either FM0 baseband or Miller-modulated subcarrier.

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9.4 Supported commands

The UCODE 8/8m supports all **mandatory** EPCglobal V2.0.1 commands including

- KILL command
- PERMALOCK or LOCK command

In addition the UCODE8/8m supports the following **optional** commands:

- ACCESS
- Block Write (32 bit) on even addresses
- Untraceable

9.5 UCODE 8/8m memory

The UCODE 8/8m memory is implemented according to EPCglobal V2.0.1:

Table 5. UCODE 8 memory sections

Name	Size	Bank
Reserved memory (32-bit Access and 32 bit Kill password)	64 bit	00b
EPC (excluding 16 bit CRC-16 and 16-bit PC)	128 bit	01b
UCODE 8 Configuration Word	16 bit	01b
TID (including permalocked unique 48-bit serial number)	96 bit	10b

Table 6. UCODE 8m memory sections

Name	Size	Bank
Reserved memory (32-bit Access and 32 bit Kill password)	64 bit	00b
EPC (excluding 16 bit CRC-16 and 16-bit PC)	96 bit	01b
UCODE 8 Configuration Word	16 bit	01b
TID (including permalocked unique 48-bit serial number)	96 bit	10b
User Memory	32 bit	11b

The logical address of all memory banks begins at zero (00h).

In addition to the four memory banks, one configuration word to handle the UCODE 8/8m specific features is available at EPC bank 01 address bit-200h. The configuration word is described in detail in Section 9.6.1

The TID complies to the GS1 EPC Tag Data Standard. See "EPC Tag Data Standard, Release 1.10"

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9.5.1 UCODE 8/8m overall memory map

Table 7. UCODE 8 overall memory map

Bank	Address	Type	Content	Initial	Remark
Bank 00	00h to 1Fh	reserved	Kill password	all 00h	unlocked memory
	20h to 3Fh	reserved	Access password	all 00h	unlocked memory
Bank 01 EPC	00h to 0Fh	EPC	CRC-16: refer to "EPC Global Gen2v2"		memory mapped calculated CRC
	10h to 14h	EPC	EPC length	00110b	unlocked memory
	15h	EPC	UMI	0b	hardwired to 0
	16h	EPC	XPC indicator	0b	hardwired to 0
	17h to 1Fh	EPC	numbering system indicator	00h	unlocked memory
	20h to 9Fh	EPC	EPC	[1]	unlocked memory
Bank 01 Config Word	200h	EPC	EPC check	0b	indicator bit
	201h	EPC	EPC correction	0b	indicator bit
	202h	EPC	EPC NOK	0b	indicator bit
	203h	EPC	EPC+TID	0b	action bit[2]
	204h	EPC	Brand Identifier	0b	action bit[2]
	205h	EPC	Self Adjust Cap 1	0b	indicator bit
	206h	EPC	Self Adjust Cap 0	0b	indicator bit
	207h	EPC	Self Adjust disable	0b	permanent bit[3]
	208h	EPC	RFU	0b	locked memory
	209h	EPC	max. backscatter strength	1b	permanent bit[3]
	20Ah	EPC	RFU	0b	locked memory
	20Bh	EPC	RFU	0b	locked memory
	20Ch	EPC	RFU	0b	locked memory
	20Dh	EPC	RFU	0b	locked memory
	20Eh	EPC	RFU	0b	locked memory
	20Fh	EPC	PSF flag	0b	permanent bit[3]
Bank 10 TID	00h to 07h	TID	allocation class identifier	1110 0010b	locked memory
	08h to 13h	TID	tag mask designer identifier	1000 0000 0110b	locked memory
	14h	TID	config word indicator	1b[4]	locked memory
	15h to 1Fh	TID	tag model number	TMNR[5]	locked memory
	20h to 2Fh	TID	XTID header	2000h	locked memory
	30h to 5Fh	TID	serial number	SNR	locked memory

[1] `HEX E280 6894 0000 nnnn nnnn nnnn 0000 0000` where `n` are the nibbles of the SNR from the TID
[2] Action bits: meant to trigger a feature upon a SELECT command on the related bit ref feature control mechanism, see Section 9.6.1
[3] Permanent bit: permanently stored bits in the memory; Read/Writeable according to EPC bank lock status, see Section 9.6.1
[4] Indicates the existence of a Configuration Word at the end of the EPC number
[5] See Figure 5

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Table 8. UCODE 8m overall memory map

Bank	Address	Type	Content	Initial	Remark
Bank 00	00h to 1Fh	reserved	Kill password	all 00h	unlocked memory
	20h to 3Fh	reserved	Access password	all 00h	unlocked memory
Bank 01 EPC	00h to 0Fh	EPC	CRC-16: refer to "EPC Global Gen2v2"		memory mapped calculated CRC
	10h to 14h	EPC	EPC length	00110b	unlocked memory
	15h	EPC	UMI	1b	hardwired to 1
	16h	EPC	XPC indicator	0b	hardwired to 0
	17h to 1Fh	EPC	numbering system indicator	00h	unlocked memory
	20h to 7Fh	EPC	EPC	[1]	unlocked memory
Bank 01 Config Word	200h	EPC	EPC check	0b	indicator bit
	201h	EPC	EPC correction	0b	indicator bit
	202h	EPC	EPC NOK	0b	indicator bit
	203h	EPC	EPC+TID	0b	action bit[2]
	204h	EPC	Brand Identifier	0b	action bit[2]
	205h	EPC	Self Adjust Cap 1	0b	indicator bit
	206h	EPC	Self Adjust Cap 0	0b	indicator bit
	207h	EPC	Self Adjust disable	0b	permanent bit[3]
	208h	EPC	RFU	0b	locked memory
	209h	EPC	max. backscatter strength	1b	permanent bit[3]
	20Ah	EPC	RFU	0b	locked memory
	20Bh	EPC	RFU	0b	locked memory
	20Ch	EPC	User Memory check	0b	indicator bit
	20Dh	EPC	User Memory correction	0b	indicator bit
	20Eh	EPC	User Memory NOK	0b	indicator bit
	20Fh	EPC	PSF flag	0b	permanent bit[3]
Bank 10 TID	00h to 07h	TID	allocation class identifier	1110 0010b	locked memory
	08h to 13h	TID	tag mask designer identifier	1000 0000 0110b	locked memory
	14h	TID	config word indicator	1b[4]	locked memory
	15h to 1Fh	TID	tag model number	TMNR[5]	locked memory
	20h to 2Fh	TID	XTID header	2000h	locked memory
	30h to 5Fh	TID	serial number	SNR	locked memory
Bank 11 User Memory	00h to 1Fh	UM	User Memory	all 00h	unlocked memory

[1] `HEX E280 6994 0000 nnnn nnnn nnnn` where `n` are the nibbles of the SNR from the TID
[2] Action bits: meant to trigger a feature upon a SELECT command on the related bit ref feature control mechanism, see Section 9.6.1
[3] Permanent bit: permanently stored bits in the memory; Read/Writeable according to EPC bank lock status, see Section 9.6.1
[4] Indicates the existence of a Configuration Word at the end of the EPC number
[5] See Figure 5

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9.5.2 UCODE 8/8m TID memory details

	First 48 bit of TID memory	Class ID	Mask Designer ID	Model Number			XTID Header
				Config Word Indicator	Sub Version Nr.	Version (Silicon) Nr.	
UCODE 8	E28068942000	E2h	806h	1b	0001b	0010100b	2000h
UCODE 8m	E28069942000	E2h	806h	1b	0011b	0010100b	2000h

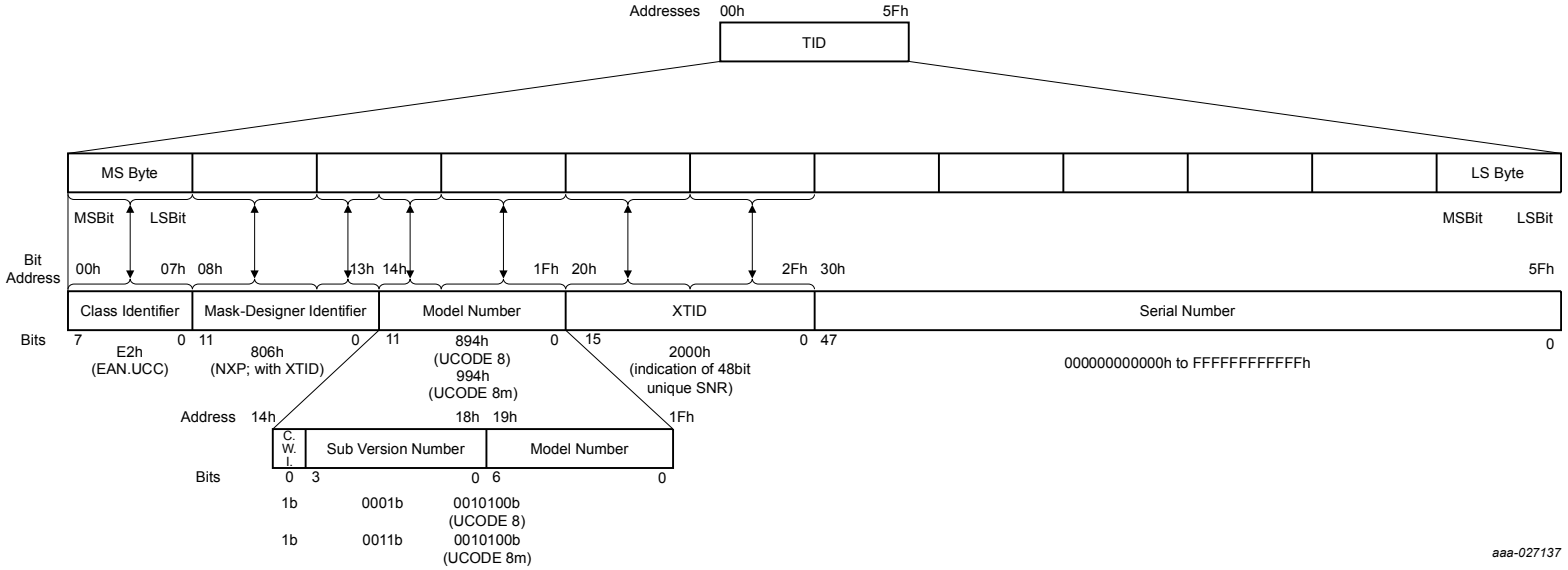


Figure 5. UCODE 8/8m TID memory structure

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9.6 Supported features

The UCODE 8/8m is equipped with a number of additional features. They are implemented in such a way that standard EPCglobal READ / WRITE / ACCESS / SELECT commands can be used to operate these features.

The Configuration Word, as mentioned in the memory map, describes the additional features at address 200h of the EPC memory.

Bit 14h of the TID indicates the existence of a Configuration Word. This flag enables the selection of configuration word enhanced transponders in mixed tag populations.

9.6.1 UCODE 8/8m features control mechanism

The different features of the UCODE 8/8m can be activated / de-activated by addressing or changing the content of the corresponding bit in the configuration word at address 200h in the EPC memory bank (see Table 9). The de-activation of the action bit features will only happen after chip reset.

Table 9. Configuration word UCODE 8/8m

Indicator bit			Action bit		Indicator bit		Permanent bit
EPC Check	EPC Corr	EPC NOK	EPC+TID	Brand Identifier	Self Adjust Cap 1	Self Adjust Cap 0	Self Adjust disable
0	1	2	3	4	5	6	7

Table 10. Configuration word UCODE 8/8m ... continued

Locked memory	Permanent bit	Locked memory		Indicator bit			Permanent bit
RFU	max.backscatter strength	RFU	RFU	User Memory Check	User Memory Corr	User Memory NOK	PSF bit
8	9	10	11	12	13	14	15

The configuration word contains 3 different type of bits:

- **Action bits**: meant to trigger a feature upon a SELECT command on the related bit:
  EPC+TID
  Brand Identifier
- **Permanent bits**: permanently stored bits in the memory
  Self Adjust disable
  Max. Backscatter Strength
  PSF Alarm bit
- **Indicator bits**: cannot be changed by command
  EPC Check/Corr/NOK
  User Memory Check/Corr/NOK
  Self Adjust Cap0/Cap1

The activation or the de-activation of the feature behind the permanent bits happens only when attempting to write a "1" value to the related bit (value toggling) - writing "0" value has no effect. If the feature is activated, the related bit will be read with a "1" value and, if

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de-activated, with a "0" value. The permanent bits can only be toggled by using standard EPC WRITE (not a BlockWrite) if the EPC bank is unlocked or within the SECURED state if the EPC is locked. If the EPC is permalocked, they cannot be changed.

Action bits will trigger a certain action only if the pointer of the SELECT command exactly matches the action-bit address (i.e. 203h or 204h), if the length=1 and if mask=1b (no multiple triggers of actions possible within one single SELECT command).

If the truncate bit in the SELECT command is set to "1", the SELECT will be ignored. A SELECT on action bits will not change the digital state of the chip.

The action bits can be triggered regardless if the EPC memory is unlocked, locked or permalocked.

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9.6.2 Memory Safeguard

9.6.2.1 Description

The Memory Safeguard of UCODE 8/8m consist of three different countermeasures which ensure integrity of the stored data:

ECC (Error correction code):

The implemented ECC is applied on the EPC- and User-Memory. With this feature, a single bit failure in the memory is detected and corrected automatically. In case of 2 bit fail, an indication is given.

EPC Memory:

The config word bit 200h (EPC check) indicates, if the EPC check is active ("1"). In case a single bit was corrected this will be indicated by the bit 201h (EPC Corr). Should a 2-bit failure occurs bit 202h (EPC NOK) will be activated ("1"). In this case, no error correction will be applied and the EPC memory content readout will provide the actual content.

User Memory:

The config word bit 20Ch (User Memory check) indicates if the User Memory check is active ("1"). In case a single bit was corrected this will be indicated by the bit 20Dh (User Memory Corr). Should a 2-bit failure occurs, bit 20Eh (User Memory NOK) will be activated ("1"). In this case, no error correction will be applied and the User Memory content readout will provide the actual content.

This feature will be activated in case a Lock operation is applied on the according to memory bank. If there is a password lock and a change of the memory content in the secured state, the ECC will be not re-calculated and the feature is disabled. To re-enable the ECC functionality also in this condition, an unlock and re-lock is required.

Parity check:

A parity check on the TID is implemented to offer the possibility to identify a change in the TID. The parity bit (Even parity) will be calculated and locked in the manufacturing process. For a check, the TID content needs to be read out and parity checked.

Margin Check

The implemented margin check is acting on the EPC-, Reserved- and User-Memory. During performing a Lock operation on the targeted memory bank the IC checks for sufficient programming margin of the memory cell and only responds after a successful check. In case of insufficient margin an error code will be responded and the Lock not completed. A re-check on already locked memory banks requires an unlock and re-lock command.

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9.6.3 Self Adjust

9.6.3.1 Description

The UCODE 8/8m has an automatic mechanism implemented which adjusts the chip sensitivity to a maximum in the operated environment. This adjustment will be performed at startup and selects between three different input capacitance values. The feature is enabled by default, but can also be deactivated by the config word bit 207h (Self Adjust disable). In case of deactivation, the center capacitance is used.

The indicator bits 205h (Self Adjust Cap 1) and 206h (Self Adjust Cap 0) give information which capacitor is active ("1"). The startup is performed with the lowest value which is center capacitance minus Cap 0 (60 fF) and is then adjusted up to center capacitance plus Cap 1 (100 fF).

9.6.4 Brand Identifier

9.6.4.1 Description

This new feature allows brand owners to implement a product originality check option for their products. The customer dedicated unique 16-bit brand identifier is programmed during manufacturing process by NXP and therefore unalterable stored in the memory.

A SELECT command on bit 204h (Brand identifier) in the configuration word triggers the UCODE8/8m to respond in the inventory round with PC + EPC + Brand Identifier + CRC. In order to prevent manipulation, the Brand Identifier is scrambled with the RN16 and not sent in plain. The implemented scrambling is performed by bitwise XOR operation of the 16-bit Brand Identifier and the RN16. At the reader, the Brand identifier can be descrambled and the originality check completed.

The PC value is adjusted accordingly for UCODE 8/8m. A SELECT on the Brand Identifier bit always gives a Tag matching.

The usage of this feature requires an update on the reader firmware with the Brand Identifier check routine.

Default value of the UCODE 8/8m Brand Identifier is "AAAAh". Customer-specific Brand Identifiers can be requested by a dedicated product ordering code. For details, contact your NXP sales representative.

The Brand Identifier feature cannot be used in combination with the EPC+TID feature.

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9.6.5 EPC+TID

9.6.5.1 Description

This feature enables the read out the EPC+TID memory content in a faster way compared to a standard readout sequence.

A SELECT on the config word bit 203h (EPC+TID) will trigger the UCODE 8/8m to reply with the EPC+TID after receiving the ACK command during the inventory round.

In case only the TID should be replied by this feature, the EPC length in the PC needs to be set to "0".

9.6.6 Product Status Flag (PSF)

9.6.6.1 Description

The PSF bit can be used for easy EAS (Electronic Article Surveillance) implementations or as general-purpose check flag.

In order to detect tags with activated PSF, a SELECT command on bit 20Fh (PSF Bit) in the configuration word is required. In the following inventory round, only PSF enabled chips reply their EPC number.

9.6.7 Backscatter strength reduction

The UCODE 8/8m features two levels of backscatter strengths. Per default, maximum backscatter is enabled in order to enable maximum read rates. A deactivation of this feature can be done by clearing bit 209h (max. backscatter strength) in the configuration word, which reduces the backscatter strength if needed.

9.6.8 Pre-serialization of the 96-bit EPC

9.6.8.1 Description

UCODE 8/8m are delivered with a pre-serialized content of the 96-bit EPC, which is the initial EPC length settings of UCODE 8/8m.

The EPC content is identical to the TID content except of the 16-bit XTID content which is set to 16-bit 0's.

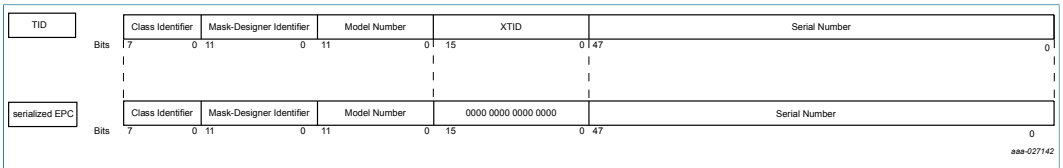


Figure 6. Pre-serialization of 96-bit EPC

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9.6.9 Single-slit antenna solution

9.6.9.1 Description

In UCODE 8/8m, the test pads TP1 and TP2 are electrically disconnected and therefore can be safely short-circuited to the RF pads (RF1, RF2) (see figure below).

Single-slit antenna enables easier assembly and antenna design. In addition to the standard antenna assembly, the related increased input capacitance (see Table 14) can be used for optimization for different antenna design.

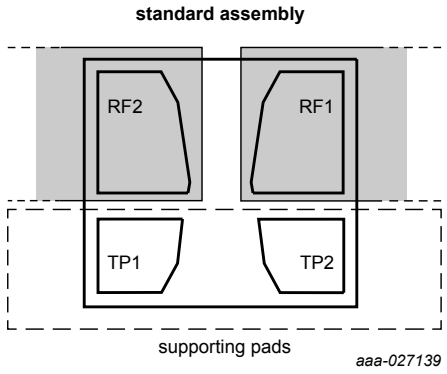


Figure 7. Standard antenna design versus single-slit antenna

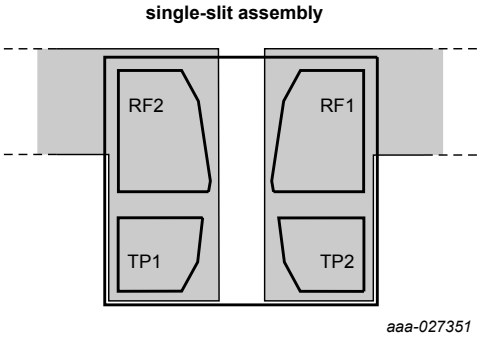


Figure 8. Single-slit assembly

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9.6.10 Large Pads

9.6.10.1 Description

The large gold pads introduced in UCODE 8/8m enable more robust and reliable assembly. The new pad design allows not only more freedom in the placement accuracy (see "Rotation tolerant pad design"). It also brings advantages in high-speed assembly due to the dual axis glue spacer (see "Dual axis glue spacer").

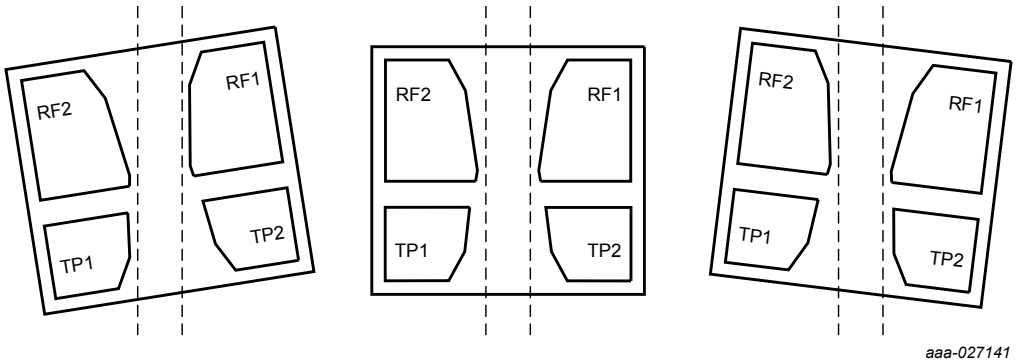


Figure 9. Rotation tolerant pad design

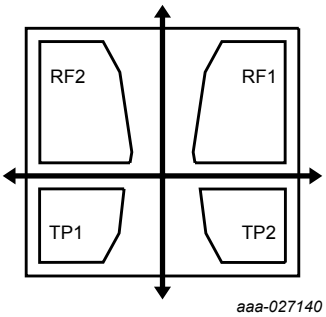


Figure 10. Dual axis glue spacer

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9.6.11 Custom commands

The Untraceable function allows the UCODE 8/8m to hide the complete or parts of the EPC, TID and/or user memory. In addition, the read range can be completely or temporarily reduced. This command can only be executed from the secured state. Memory parts which are set untraceable are acting as non-existing in the Open state.

EPC-field: Specifies the number of words of the EPC memory which the UCODE 8/8m back scatters. A change of this field therefore also changes the L bit in the Protocol Control (PC) word.

TID-field: Hide some ("01") hides the TID memory from address 20h (included) onwards.

Range-field: In case of activated range toggling, the read range reduction toggles from the actual value to the second (e.g. when actual state is normal it toggles to reduced). In case of power loss the chip reverts to its prior state.

UCODE 8/8m does not support the U bit and therefore ignores this value.

Table 11. Untraceable command

	Command	RFU	U	EPC	TID	User	Range	RN	CRC
No. of bits	16	2	1	6	2	1	2	16	16
Description	1110 0010 0000 0000	00	do not care	MSB:"0": show memory above EPC "1": hide memory above EPC 5 LSBs: new EPC length	"00": hide none "01": hide some "10": hide all "11": RFU	"0": view "1": hide	"00": normal "01": toggle "10": reduced "11": RFU	handle	CRC-16

Table 12. Untraceable command-response table

Starting State	Condition	Response	Next State
ready	all	-	ready
arbitrate, reply, acknowledged	all	-	arbitrate
open	all	-	open
secured	executable	backscatter header when done	secured
killed	all	-	killed

In case of access to the memory that is set to untraceable, the error condition "memory overrun" is returned.

For further details, refer to "EPC Global Gen2v2"

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10 Limiting values

Table 13. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to RFN. [1] [2]

Symbol	Parameter	Conditions		Min	Max	Unit
Bare die limitations						
T_{stg}	storage temperature			-55	+125	°C
T_{amb}	ambient temperature			-40	+85	°C
V_{ESD}	electrostatic discharge voltage	Human body model	[3]	-	± 2	kV
Pad limitations						
P_i	input power	maximum power dissipation, RF1/RF2 pad		-	100	mW

[1] Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any conditions other than those described in the Operating Conditions and Electrical Characteristics section of this specification is not implied.

[2] This product includes circuitry specifically designed for the protection of its internal devices from the damaging effects of excessive static charge. Nonetheless, it is suggested that conventional precautions be taken to avoid applying greater than the rated maxima.

[3] For ESD measurement, the die chip has been mounted into a CDIP20 package.

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the *ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A* or equivalent standards.

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11 Characteristics

11.1 UCODE 8/8m bare die characteristics

Table 14. UCODE 8/8m RF interface characteristics (RF1, RF2)

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
f_i	input frequency			840	-	960	MHz
$P_{i(min)}$	minimum input power	READ sensitivity	[1] [2] [3]	-	- 22.9	-	dBm
		reduced operating range	[4]	-	+ 1	-	dBm
$P_{i(min)}$	minimum input power	WRITE sensitivity	[4]	-	-17.8	-	dBm
t 16bit	encoding speed	16-bit	[5]	-	0.7	-	ms
		32-bit (block write)	[5]	-	1.2	-	ms
C_i	chip input capacitance	parallel	[2] [6] [7]	-	0.69	-	pF
Z	chip impedance	866 MHz	[2] [6] [7]	-	15-j265	-	Ω
		915 MHz	[2] [6] [7]	-	14-j252	-	Ω
		953 MHz	[2] [6] [7]	-	13-j242	-	Ω
Z	typical assembled impedance (see Figure 7)	915 MHz	[8] [9] [7]	-	19-j234		Ω
Z	typical assembled impedance in case of single-slit antenna assembly (see Figure 8)	915 MHz	[8] [10] [7]		13-j191	-	Ω

[1] Power to process a QUERY command
[2] Measured with a 50 Ω source impedance directly on the chip
[3] Results in approximately -23 dBm tag sensitivity with a 2.15 dBi gain antenna
[4] Tag sensitivity on a 2.15 dBi gain antenna
[5] When the memory content is "0000...".
[6] At minimum operating power
[7] at center capacitor of Self Adjust
[8] The antenna shall be matched to this impedance
[9] Assuming 50ff additional assembly capacitance
[10] Assuming 220ff additional assembly+test pad capacitance

Table 15. Table 13.UCODE 8/8m memory characteristics

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
EEPROM characteristics							
t_{ret}	retention time	T_{amb} ≤ 55 °C		20	-	-	year
$N_{endu(W)}$	write endurance			100k	-	-	cycle

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12 Packing information

12.1 Wafer

See "Data sheet - Delivery type description – General specification for 8" wafer on UV-tape with electronic fail die marking, BU-S&C document number: 1093**"

See "Data sheet - Delivery type description – General specification for 12" wafer on UV-tape with electronic fail die marking, BU-S&C document number: 1862**"

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13 Abbreviations

Table 16. Abbreviations

Acronym	Description
CRC	Cyclic Redundancy Check
CW	Continuous Wave
DSB-ASK	Double Side Band-Amplitude Shift Keying
DC	Direct Current
EAS	Electronic Article Surveillance
EEPROM	Electrically Erasable Programmable Read Only Memory
EPC	Electronic Product Code (containing Header, Domain Manager, Object Class and Serial Number)
FM0	Bi phase space modulation
G2	Generation 2
IC	Integrated Circuit
PIE	Pulse Interval Encoding
PSF	Product Status Flag
RF	Radio Frequency
UHF	Ultra High Frequency
SECS	Semi Equipment Communication Standard
TID	Tag IDentifier

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14 References

1. EPCglobal: EPC Radio-Frequency Identity Protocols Class-1 Generation-2 UHF RFID Protocol for Communications at 860 MHz – 960 MHz, Version 2.0.1 (April 2015)
2. EPCglobal: EPC Tag Data Standard, Release 1.10 (March 2017)
3. Data sheet - Delivery type description – General specification for 8" wafer on UV-tape with electronic fail die marking, BU-S&C document number: 1093**
4. Data sheet - Delivery type description – General specification for 12" wafer on UV-tape with electronic fail die marking, BU-S&C document number: 1862** [1]

1 ** ... document version number

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15 Revision history

Table 17. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
SL3S1205_15 v. 3.2	20181119	Product data sheet	-	SL3S1205_15 v. 3.1
Modifications:	• Introduction of 12 inch wafer delivery • Figure 3 "UCODE 8/8m, 8" wafer layout" updated • Editorial changes in Table 7 "UCODE 8 overall memory map" • Editorial changes in Table 8 "UCODE 8m overall memory map" • Section 9.6.4 "Brand Identifier" updated			
SL3S1205_15 v. 3.1	20170630	Product data sheet	-	SL3S1205_15 v. 3.0
Modifications:	• Wording: "Auto Adjust" replaced with "Self Adjust"			
SL3S1205_15 v. 3.0	20170703	Product data sheet	-	398420
398420	20170531	Preliminary data sheet	-	398410
398410	20160919	Objective data sheet	-	-

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16 Legal information

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Document status[1][2]	Product status[3]	Definition
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Product [short] data sheet	Production	This document contains the product specification.

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Date of release: 19 November 2018
Document number: 398432